Plasmoid-Induced Turbulence in 3D Kinetic Reconnection

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Multi-Scale Nature of Reconnection







Impact of Dissipation Mechanism

Ugai, Phys. Plasmas, 1995 MHD simulations

Uniform η



 ∂B $= \eta \nabla^2 B / \mu_0$ ∂t

Localized η



Kuznetsova et al., J. Geophys. Res., 2007

Nongyrotropic



=

 m_i

 $\overline{2P}\partial V_x$

 $\overline{\partial P_{ixz}}$

Numerical resistivity only



- Slow reconnection
- Quasi-steady configuration
- Fast reconnection
- Quasi-periodic process



 $\overline{\partial P_{ixy}} +$

1

 $_E$ ng

Dissipation in 2D Kinetic Reconnection



PIC simulations

$$-E_y \approx \frac{1}{ne} (\nabla \cdot P_e)_y$$
 at x-line

Electron viscosity

[Cai & Lee, 1997; Hesse et al., 1999]



$$-\frac{1}{n_e e} \nabla \cdot P_e \approx E_y \left[1 - \frac{5}{2} \left(\frac{z}{\delta_e} \right)^2 \right] = E_y$$
Fluid
Particle
[Fujimoto & Sydora, 2009]
Inertia resistivity
$$\eta_{in} = \frac{m_e}{n_e e^2} \frac{1}{\tau_{tr}}$$

$$\tau_{tr}$$
Transit time througe

Transit time through the diffusion region

Inertia Resistivity & Current Sheet Width

$$E_y = \eta_{in} j_y$$
 at the x-line

 $E_y = -V_{in}B_{in}$ outside the current layer $\frac{m_e}{-\frac{1}{2}} \approx \frac{m_e}{2} \frac{V_{in}}{\delta_e}$

$$\eta_{in} = \frac{me}{n_e e^2} \frac{1}{\tau_{tr}} \approx \frac{me}{n_e e^2} \frac{1}{\delta}$$
$$j_y \approx -\frac{1}{\mu_0} \frac{B_{in}}{\delta_e}$$







Implication of Anomalous Effects: Lab. Experiment



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Implication of Anomalous Effects: Satellite Observation



Cluster 2001/10/01 (Day 274), 09:46:28.147 - 09:47:06.030



[Wygant et al, JGR, 2005]



[Zhou et al, JGR, 2009]

Implication of Anomalous Effects

$$E_{y} = (\eta_{in} + \eta) j_{y} \text{ at the x-line}$$

$$E_{y} = -V_{in}B_{in} \text{ outside the current layer}$$

$$\eta_{in} = \frac{m_{e}}{n_{e}e^{2}}\frac{1}{\tau_{tr}} \approx \frac{m_{e}}{n_{e}e^{2}}\frac{V_{in}}{\delta_{e}}$$

$$j_{y} \approx -\frac{1}{\mu_{0}}\frac{B_{in}}{\delta_{e}}$$

$$\delta_{e} \approx \frac{\lambda}{2} + \sqrt{\left(\frac{\lambda}{2}\right)^{2} + \lambda_{e}^{2}} > \lambda_{e} = \frac{c}{\omega_{pe}} \quad \text{[Vasyliunas, 1975]}$$

$$\lambda \equiv \frac{\eta}{\mu_{0}V_{in}} \quad \text{(Resistive length)}$$
Could be caused by wave-particle

interactions.

Dynamical Current Sheet (2D PIC simulation)

/home/fkeizo/AMR_code/2d_main_cyc_r/output/x10z9rng3bn44p/part/03569.fld





Instabilities in the Harris Current Sheet

Tearing instability



AMR-PIC Simulations [Fujimoto, JCP, 2011]





de/3d_main_cyc_3/output/x1y5z8rng3bn44p/part/yzx0.00_087_1111.inp



0.00 0.10 0.20 0.30 0.40 0.50 0.60 0.70 0.80 0.90 1.00

Simulation Setup





 $m_{i}/m_{e} = 100$

Fujitsu FX1

Max resolution: $4096 \times 512 \times 4096 \sim 10^{10}$

Max number of particles Ion + Electron ~ 10^{11}

Max memory used ~ 6TB

Time Evolution of the Current Sheet

Surface: |J|, Line: Field line Color on the surface: Ey, Cut plane: Jy





Anomalous Momentum Transport



$$\begin{aligned} \langle -E_y \rangle &= \frac{1}{\langle n_e \rangle} \left(\left\langle n_e \vec{V}_e \right\rangle \times \left\langle \vec{B} \right\rangle \right)_y \\ &+ \frac{1}{e \langle n_e \rangle} \left\langle \nabla \cdot \vec{P}_e \right\rangle_y \\ &+ \frac{m_e}{e \langle n_e \rangle} \left\langle \frac{\partial V_{ey}}{\partial t} + \vec{V}_e \cdot \nabla V_{ey} \right\rangle \\ &+ \frac{1}{\langle n_e \rangle} \left\langle \delta n_e \delta E_y \right\rangle \\ &+ \frac{1}{\langle n_e \rangle} \left\langle \delta (n_e \vec{V}_e) \times \delta \vec{B} \right\rangle_y \end{aligned}$$

Anomalous effects



Anomalous Transport at the X-line



Plasmoid-Induced Turbulence



$$\Delta t = 1.6 \omega_{ci}^{-1}$$

$$L_{XO} = 0.95 \lambda_i^*$$
Information
propagates at
$$V_p \sim V_A^*$$

$$(B^* = 0.5B_0)$$

Plasmoid-Induced Turbulence



Wave Properties

 $\omega = \omega_r + \mathbf{i}\gamma$

Simulation results



Linear Analyses





Large-scale 3D PIC simulations using AMR-PIC code

The EM turbulence has a significant impact on the dissipation mechanism during the fast reconnection, in association with plasmoid formations.

The properties of the EM mode responsible for the turbulent electron flow.

 $\omega_{ci} < \omega_{r} < \omega_{LH}$

Shear driven instability

Large growth rate even for $m_i/m_e = 1836$